

# 2023 CETS school

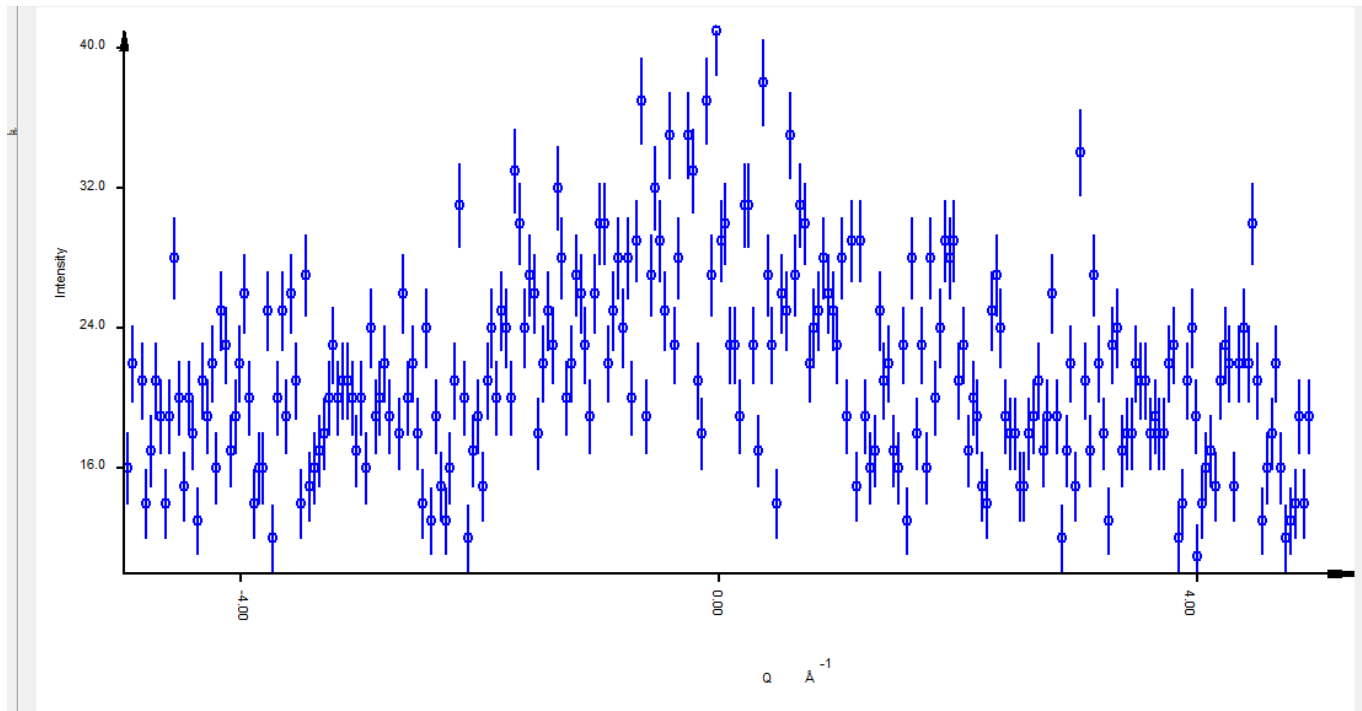
## Data treatment

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*After hard work you have got nice data...*

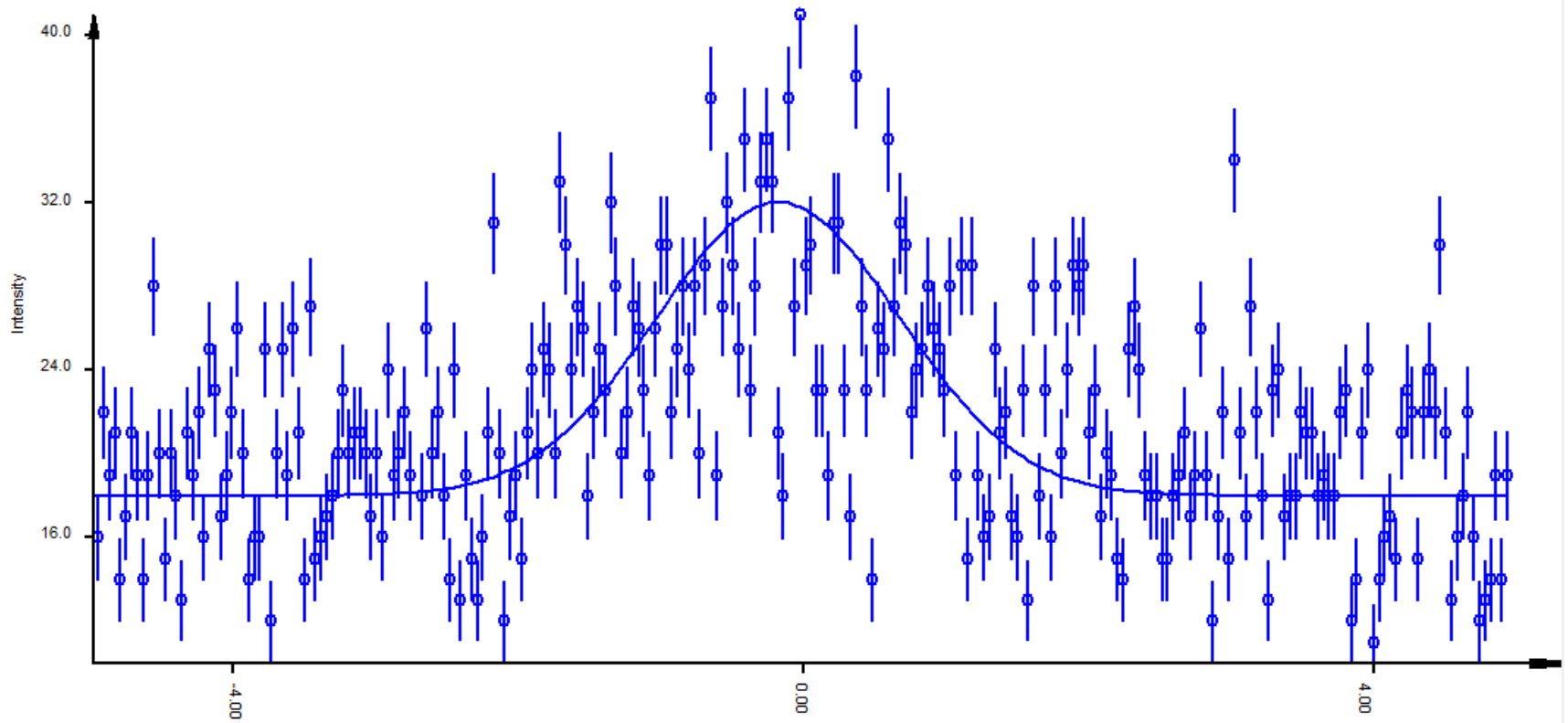


*File example from Kuklin A., FLNP, JINR, Dubna*

*You just want to click on a button...*

**Run the fit**

*In order to get a nice fit !*



*However there is a high probability  
that you get into trouble...*



*Hopefully this lecture will help you  
understand the fit process and avoid traps.*

## **Summary:**

**1 - probabilities**

**2 - data treatments**

**3 - examples**

*Most texts and pictures were found in Wikipedia articles, unless otherwise quoted.*

$$Var(X) = \frac{1}{n} \sum_{i=1}^n (x_i - \lambda)^2$$

## Some definitions

-  $X$  a discrete random variable

-  $\lambda$  its average

$$\lambda = \frac{1}{n} \sum_{i=1}^n x_i$$

-  $var(X)$  its variance

It is a measure of its dispersion

$$Var(X) = \frac{1}{n} \sum_{i=1}^n (x_i - \lambda)^2$$

-  $\sigma$  its standard deviation

$$\sigma = \sqrt{Var(X)}$$

-The variance of the sum of **two uncorrelated random variables** is the sum of their variances:

$$Var(X+Y) = Var(X) + Var(Y)$$

which is not true for the standard deviation !

# Binomial distribution

- A binomial distribution with parameters  $n$  and  $p$
- is the discrete probability distribution of success
  - in a sequence of  $n$  independent experiments,
  - each asking a yes–no question,
  - *success* (with probability  $p$ ) or *failure* (with probability  $q = 1 - p$ )

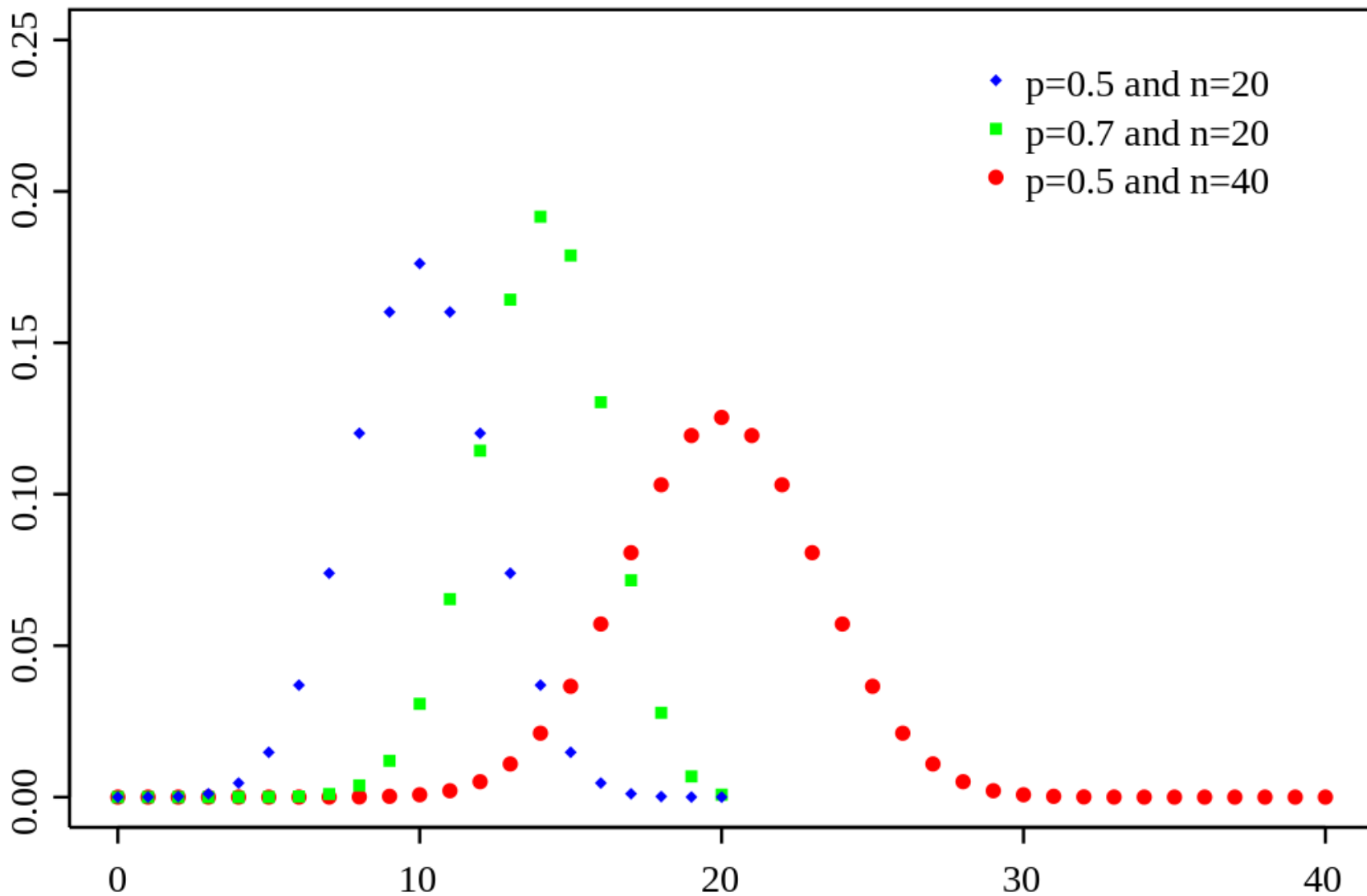
Probability of having  $k$  successes in  $n$  trials:

$$\Pr(X = k) = \frac{n!}{k! (n - k)!} p^k (1 - p)^{n-k}$$

Average  $\lambda = np$  (if  $np$  is an integer)

Variance  $\text{Var}(X) = np.(1-p)$

# Binomial examples

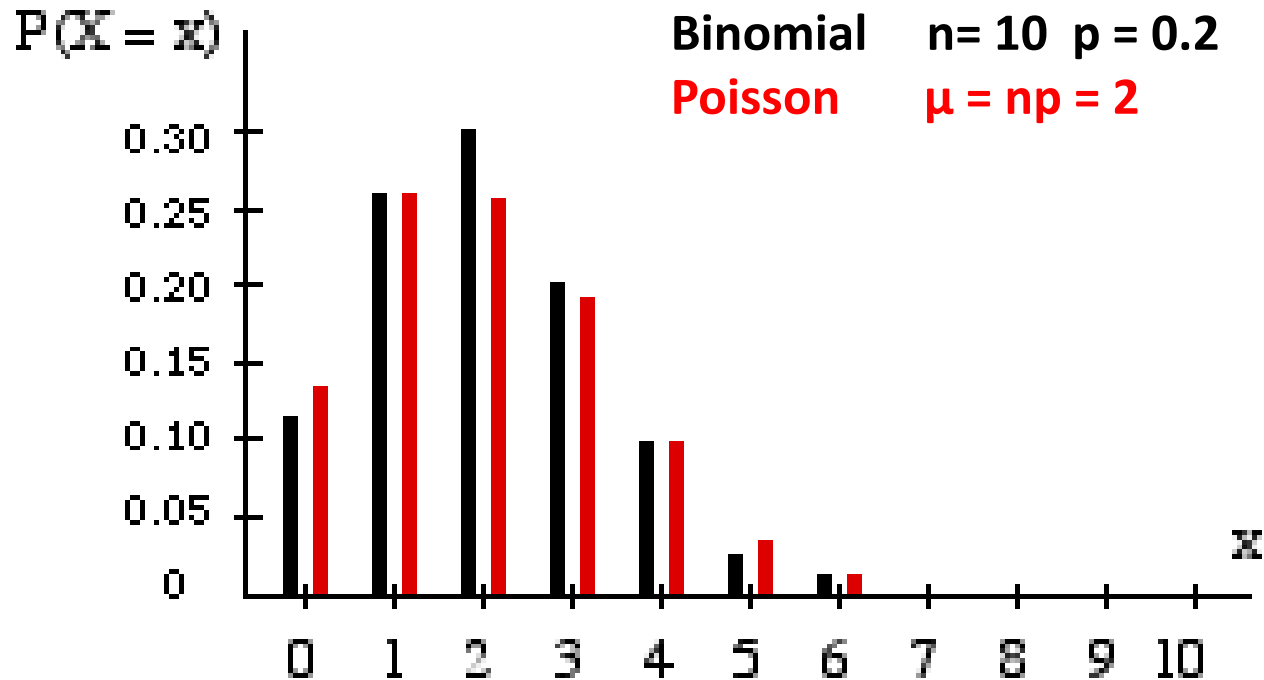




## Poisson approximation

In a binomial distribution if  $n$  is big and  $p$  is small a Poisson distribution is a good approximation.

Typically this approximation is good if  $n > 20$  and  $p < 0.05$



# Poisson distribution

- A discrete probability distribution for the probability of
- a given number of events
  - occurring in a fixed interval of time or space
  - if these events occur with a known constant mean rate
  - and independently of the time since the last event.

**This is what happens in a gas neutron detector !**

Poisson distribution  $\Pr(X = k) = \frac{\lambda^k e^{-\lambda}}{k!}$

Average  $\lambda$

Variance  $\text{Var}(X) = \lambda$

# Central limit theorem

CLT states that, in many situations, when independent random variables are summed up, their properly normalized sum tends toward a normal distribution even if the original variables themselves are not normally distributed.

Therefore for large values, say  $\lambda > 1000$ , the normal distribution is an excellent approximation to the Poisson distribution.

If  $\lambda > 10$ , then the normal distribution is a good approximation if correction is performed, i.e., if  $P(X \leq x)$  is replaced by  $P(X \leq x + 0.5)$ .

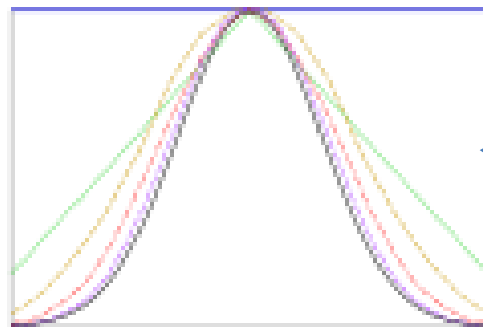
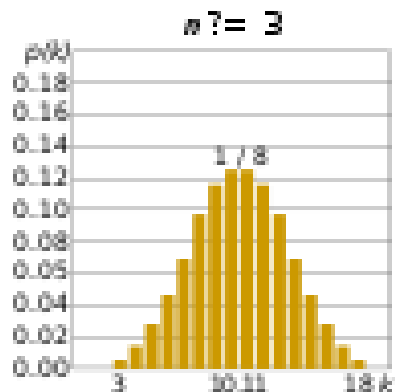
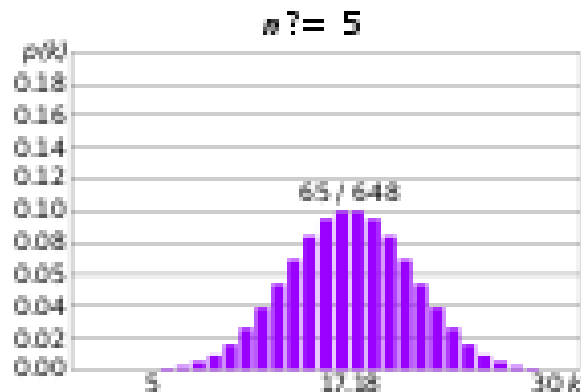
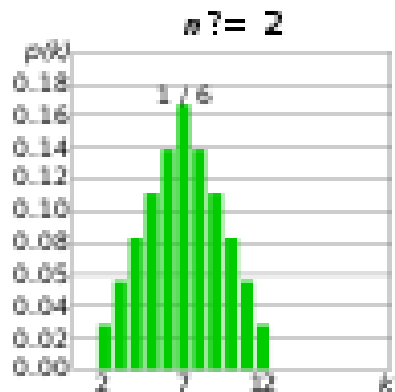
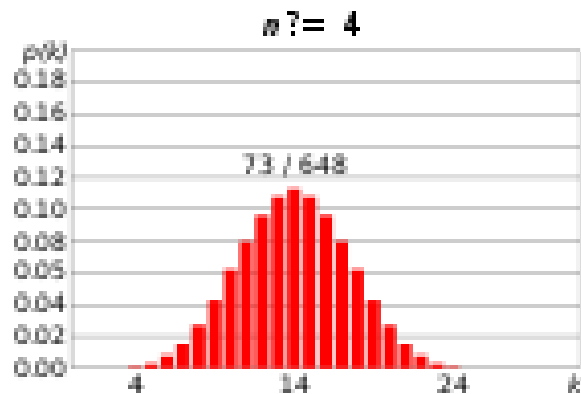
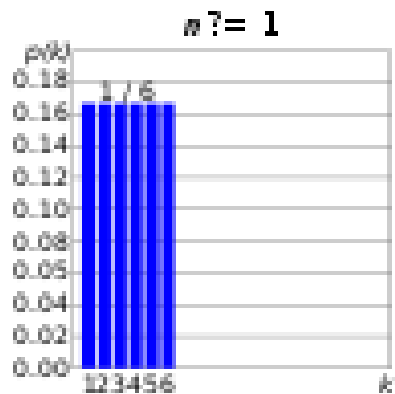
# The normal distribution

*In many detectors (notably gas detectors, but not CCDs !) counting follows a Poisson distribution law. As soon as the counting rate is high the « normal law » becomes a good approximation. It is much easier to handle.*

**Normal distribution:**

$$\Pr(X = x) = \frac{\exp\left(-\frac{1}{2}\left(\frac{x - \lambda}{\sigma}\right)^2\right)}{\sigma\sqrt{\pi}}$$

<b>Average</b>	$\lambda$
<b>Variance</b>	$\sigma^2$
<b>Mean square deviation</b>	$\sigma$



Probability functions,  $p(k)$   
for the sum of  $n$  fair  
6-sided dice

Smoothed profiles of the  
previous graphs are rescaled,  
superimposed and compared  
with a normal distribution  
(black curve).

**Problem with the Poisson -> normal approximation:  
the normal distribution is symmetric  
which means that for **small numbers**  
exists a significant non-zero probability for negative occurrences !**

**Impossible in real life !**

# Fitting a model

Whatever the model appropriate for the observed scattering, you need a test function to appreciate the quality of the fit.

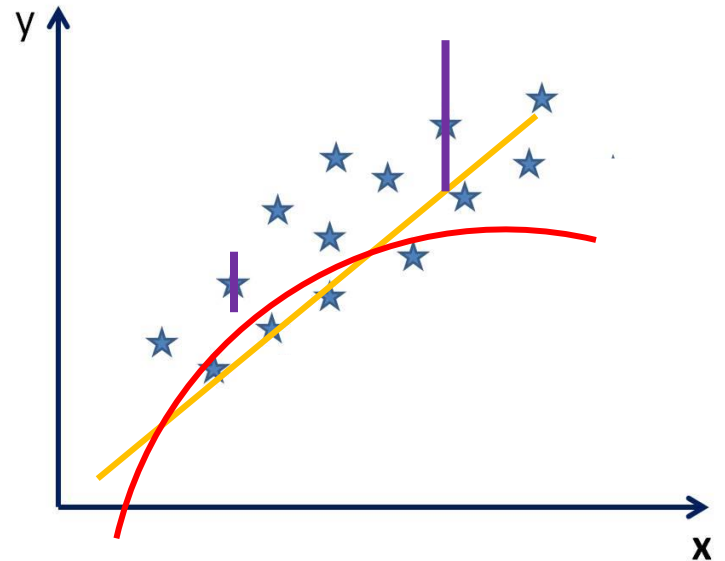
Such a function is **a distance**.

Several distances are known, for 2 points with coordinates  $\{x_i\}$ ,  $\{y_i\}$ :

$$1 - \text{norm distance} \quad d = \sum_{i=1}^n |x_i - y_i|$$

$$\text{Euclidian distance} \quad d = \left( \sum_{i=1}^n |x_i - y_i|^2 \right)^{\frac{1}{2}}$$

$$p - \text{norm distance} \quad d = \left( \sum_{i=1}^n |x_i - y_i|^p \right)^{\frac{1}{p}}$$



Main property of a distance: **scalar positive** function

## Distance for SANS data

$$\chi^2 = \frac{1}{N - p} \sum_{i=1}^{i=N} \left( \frac{I_i - Y_i(\{P\})}{\Delta I_i} \right)^2$$

Least squares

- $I_i$  intensity in pixel  $i$
- $N$  number of data points
- $p$  number of free parameters
- $\{P\}$  set of parameters
- $Y_i$  calculated intensity for pixel  $i$
- $\Delta I_i$  uncertainty of  $I_i$

If the random variables  $I_i$  are **independent** and follow a **normal distribution**, assuming that the normal law approximation is valid:

$$\Delta I_i = \sqrt{I_i}$$

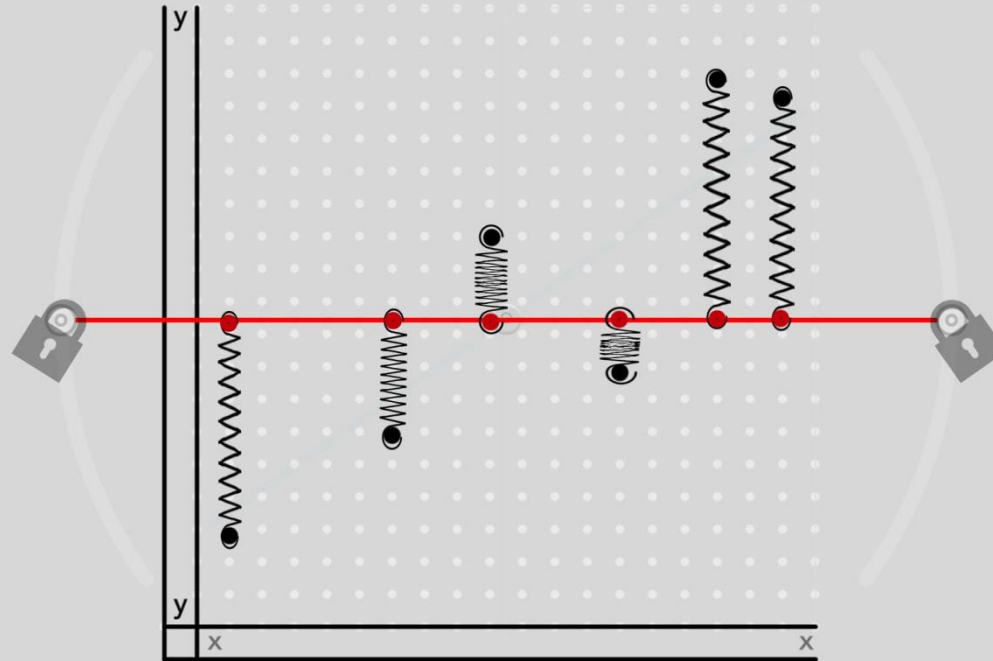
then

$$\chi^2 \rightarrow 1$$

This is a good test for the fit.



## Least squares : how does it work?



[https://www.jmp.com/en\\_in/statistics-knowledge-portal/what-is-regression/the-method-of-least-squares.html](https://www.jmp.com/en_in/statistics-knowledge-portal/what-is-regression/the-method-of-least-squares.html)

# Fitting processes

## 1 – steepest descent (gradient)

Obvious method:

Calculate the gradient of the test function and make parameter increments in the opposite direction.

The main problem is to determine what are « good » increments. Usually one calculates the test function at a set of increments along the gradient opposite direction, in order to evaluate a good step.

Not efficient. No guarantee to avoid a local minimum of the test function.

## 2 – least squares

Somewhat improved method.

- calculate a development of the  $\chi^2$  test function up to 2<sup>nd</sup> order

$$\chi^2 = \chi^2(0) + \sum_{i,j} \delta p_i \frac{\partial \chi^2}{\partial p_i} + \frac{1}{2} \delta p_i \delta p_j \frac{\partial^2 \chi^2}{\partial p_i \partial p_j}$$

- calculate the 1st order derivatives versus the parameters

$$\frac{d\chi^2}{dp_i} = \frac{\partial \chi^2}{\partial p_i} + \sum_j \delta p_j \frac{\partial^2 \chi^2}{\partial p_i \partial p_j}$$

- hypothesis : close to the  $\chi^2$  minimum all derivatives are 0

$$\frac{d\chi^2}{dp_i} = 0$$

- this hypothesis provides a linear equation system

$$\sum_j \delta p_j \frac{\partial^2 \chi^2}{\partial p_i \partial p_j} = - \frac{\partial \chi^2}{\partial p_i} \quad \text{or} \quad [\alpha] \vec{\delta p} = \vec{\beta}$$

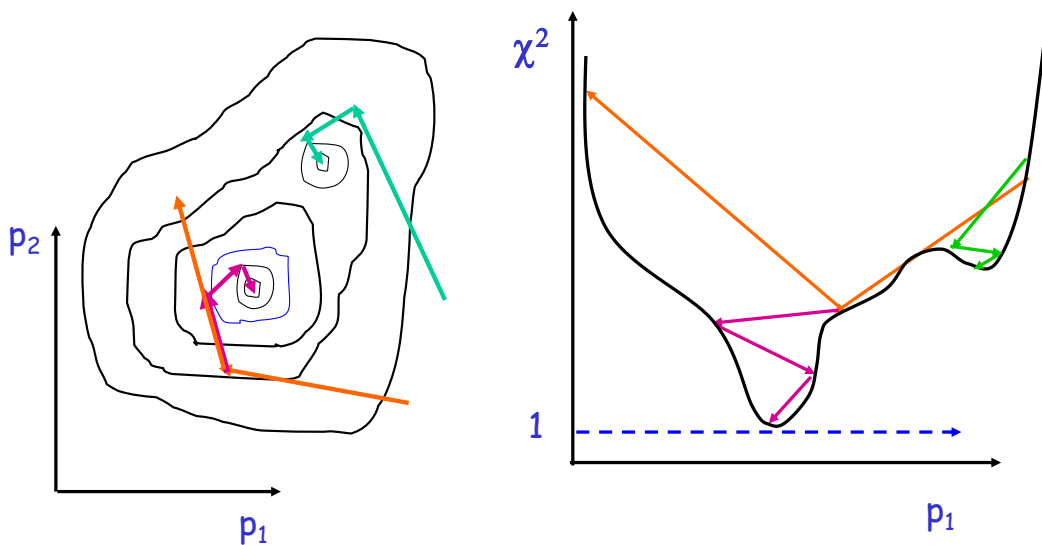
**[ $\alpha$ ]** is the *curvature matrix*

- its solution (matrix inversion) provides a vector of parameters increments.

$$\vec{\delta p} = [\alpha]^{-1} \vec{\beta} \quad \text{or} \quad \vec{\delta p} = [C] \vec{\beta}$$

**[C]** is the *covariance matrix*

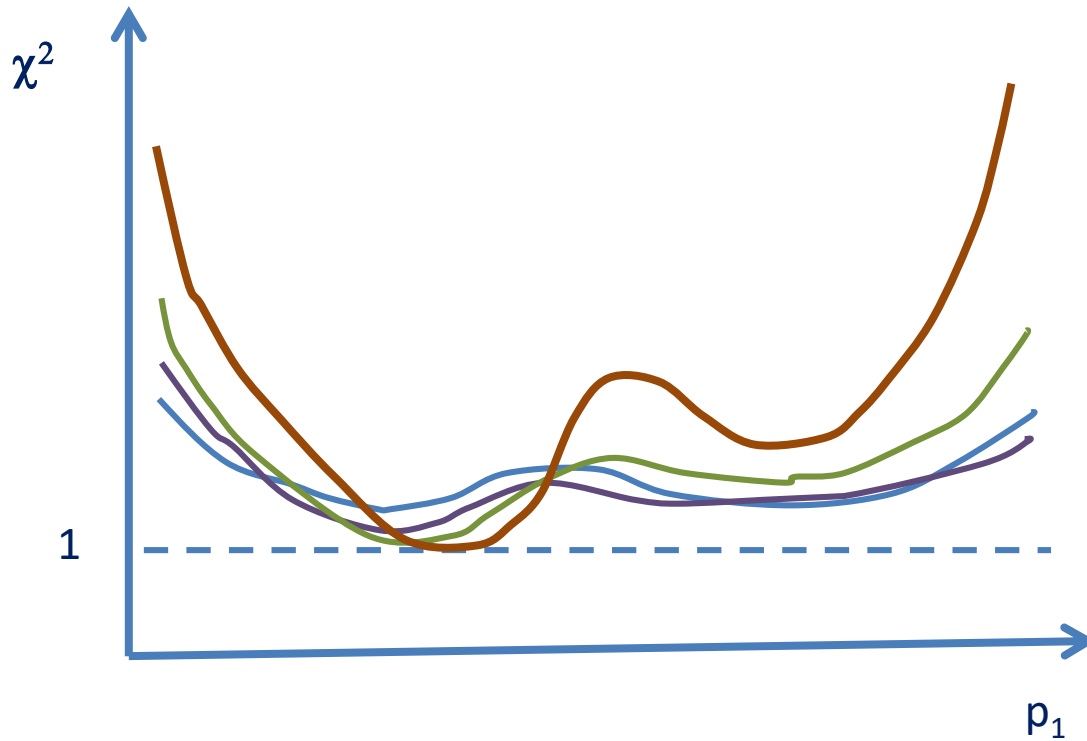
With some luck this vector leads to a point in the parameter hyperspace where  $\chi^2$  is smaller. It may not be the case as all this is highly non linear; one may try to shorten the vector keeping the same direction... Then one repeats (iterates) the process.



### Some problems:

- non linearity
- the minima depths differentiate best if the pixels **uncertainties are small**
- **systematic** errors in the data or the model ->  **$\chi^2 \neq 1$**
- nature of the probability law: Poisson or... worse
- bad evaluation of the pixel uncertainties

# $\chi^2$ in parameters hyperspace, statistics, phase transition



Notably, if the  $\chi^2$  is not a quadratic form this process is not efficient (the hypothesis and calculation on derivatives are bad)

One prefers the **steepest descent method**,  
taking a step  $C$  along the 1st derivative vector  
 $C$  is now simply a scalar.

**Levenberg-Marquardt** have proposed a clever method  
to pass from “**steepest descent**” to “**least square**” :

Replace  $[\alpha]$  by  $[\alpha]' = [\alpha] + \lambda [I]$

(i.e. multiply the diagonal elements of the curvature matrix by  $1 + \lambda$  )

1) start with a modest  $\lambda \sim 1$ ,

2) compute  $[\alpha]$  ,  $\beta$  (and save it) and  $\chi^2$  and save them

3) calculate the parameter increments with  $[\alpha]'$  diagonal  $\chi^2$  elements

4) compute new parameters and the corresponding  $\chi^2$

5) if the fit has converged, or too many iterations, stop !

6) if the fit improves, keep new parameters, divide  $\lambda$  by 10 and return to 2)

7) if the fit worsens, multiply  $\lambda$  by 10, return to 3)

( no new computation of  $[\alpha]$  needed, so it is efficient)

NOTE - to obtain the proper error estimates on parameters  
set  $\lambda = 0$  for a final calculation.

least squares

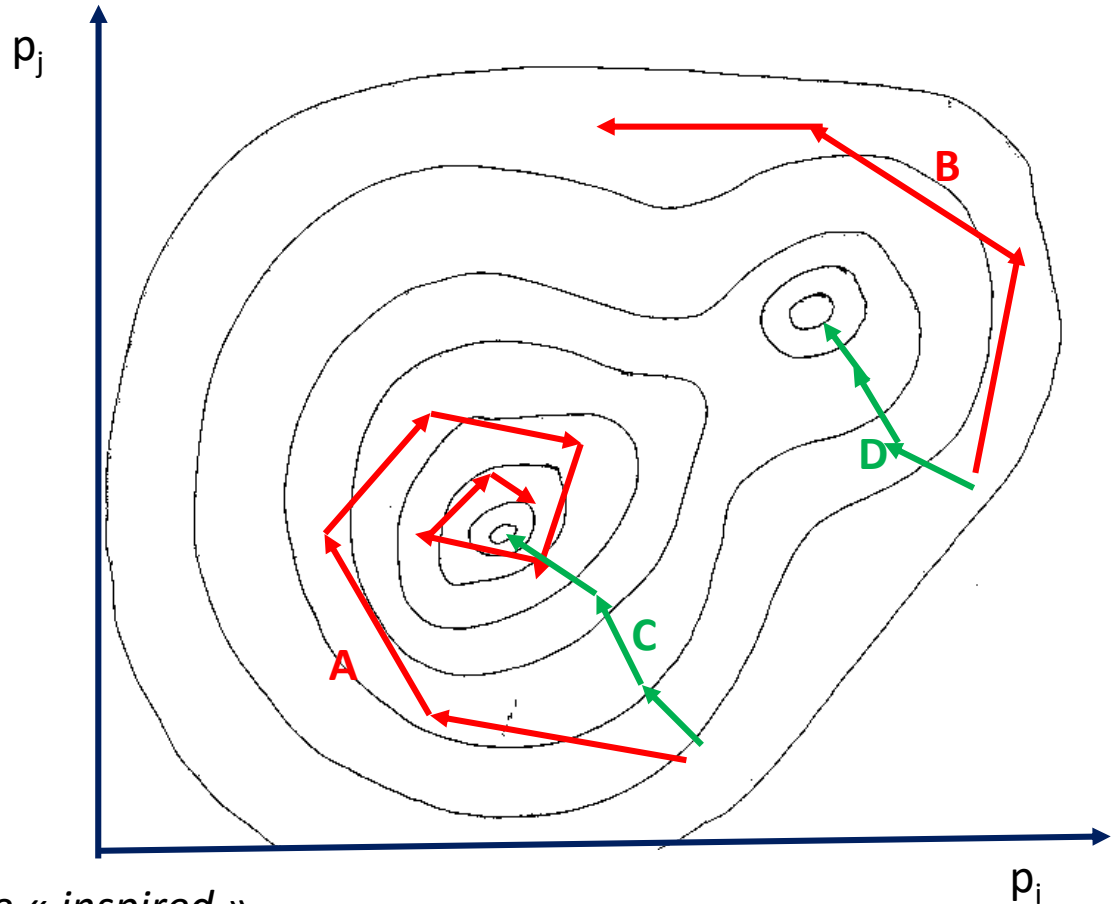
steepest descent

Levenberg- Marquardt

Schematic Least Square & Steepest Descent,  
on a 2 parameters  $\chi^2$  surface

Least squares follows A  
(well behaved, else might work  
using partial shifts)  
or B (blows up),  
steepest descent follows C  
or D (local minimum),  
Marquardt steers  
between B&D or A&C but  
might fall into the local minimum.

$\lambda$  is small for least squares or  
 $\lambda$  is large for steepest descent



*This slide and the previous one were « inspired »  
from a talk at FLNP, Dubna, by Dr. Richard Heenan, ISIS Facility,*

# SANS experiments

$\frac{d\Sigma}{d\Omega} = F_w$	smoothing	$I_s/C_s$	$- I_r/C_r$
	$I_c/C_c$	$- I_b/C_b$	

Pseudo calibration :  
averaging lines and columns

$$C_i = \frac{(L_{SDi})^2}{A_i d_i M_i T_i}$$

The C coefficients index refer to:

s sample  
r reference  
c calibration  
b background

with A beam area  
d sample thickness  
M monitor  
T transmission  
 $L_{SD}$  sample to detector distance  
 $F_w$  normalization prefactor

*Before fitting SANS scattering, one has to make basic data corrections : the most important is **calibration** (thanks to a flat scatterer like  $H_2O...$ ). Others consist in sample background or calibration background subtractions. Smoothing data may help avoid Poisson law. Pseudo-calibration decreases the effect of calibration file uncertainties. **High quality experiments exhibit small uncertainties.***



## Data error bars (uncertainties)

$$\left( \frac{d\Sigma}{d\Omega} \right) = F_w \frac{I_s/C_s - I_r/C_r}{I_w/C_w - I_c/C_c}$$

Let  
**A** area  
**d** thickness  
**M** monitor  
**T** transmission  
**L<sub>SD</sub>** sample to detector distance

$$C_s = \frac{L_{SDs}^2}{A_s d_s M_s T_s}$$

Let the index hold for  
**s** sample  
**r** reference  
**w** calibration (water)  
**c** cuvette (sample container)

$$\Delta \left( \frac{d\Sigma}{d\Omega} \right) = F_w \left\{ \frac{\Delta I_s/C_s}{I_w/C_w - I_c/C_c} + \frac{\Delta I_r/C_r}{I_w/C_w - I_c/C_c} + \frac{\Delta I_w}{C_w} \frac{I_s/C_s - I_r/C_r}{(I_w/C_w - I_c/C_c)^2} + \frac{\Delta I_c}{C_c} \frac{I_s/C_s - I_r/C_r}{(I_w/C_w - I_c/C_c)^2} \right\}$$

*Everything involved in the correction process will increase the final uncertainties.*

*In his book about "Neutron diffraction", G.E Bacon (Oxford: Clarendon Press, 1955) already warned that «**the uncertainty about background measurement must be as good as the uncertainty about sample data**»*

## Parameters error bars

The parameter error bars are best obtained after a least square fitting converges

Let us consider the  $\chi^2$  expression:  
and the  $\chi^2$  change when a single  
parameter is changed

$$\chi^2 = \chi^2_{\min} + \overline{\delta p}^t[\alpha]\overline{\delta p}$$
$$\Delta\chi_1^2 = \chi_{M-1}^2 - \chi_{\min}^2$$

It is possible to show that  $\Delta\chi_1^2$  probability distribution is a normal law

Therefore one considers  $\Delta\chi_1^2 = 1$   
**(which corresponds to a doubling of the  $\chi^2$  if  $\chi_{\min}^2=1$  !)**

and from the  $\chi^2$  development  $\Delta\chi_1^2 = (\delta p_1)^2 / C_{11}$   
with  $C_{11}$  the diagonal element of the covariance matrix for parameter 1

And as for  $\Delta\chi^2 \cong 1$   $\delta p_1 \cong 1\sigma$  (68% of cases, 1st standard deviation)

$$\delta p_i = \sqrt{C_{ii}}$$

## Limitations of Least-Squares:

- data span many orders of magnitude

-> another distance than the  $\chi^2$

For instance :absolute value instead of squares of the residuals

## Robust fitting

- significant outliers are present

(FULLPROF for diffraction, now back to  $\chi^2$ )

*Robust fitting proposes to modify the minimisation function by  $w_i$  weights.*

$$\chi^2 = \frac{1}{N - p} \sum_{i=1}^{i=N} (w_i e_i)^2 \quad e_i = \frac{I_i - Y_i \{P\}}{\Delta I_i}$$

- li** intensity in pixel i
- N** number of data points
- P** number of free parameters
- {P}** set of parameters
- Yi** calculated intensity in pixel i
- $\Delta I_i$**  uncertainty of li
- $w_i$**  weight
- $e_i$**  estimator / residual

model	parameter k	$e_i < k$	$e_i > k$
Huber	1.345	$w_i = 1$	$w_i = k/e_i$
bisquare	4.685	$w_i = (1 - (e_i/k)^2)^2$	$w_i = 0$

Huber P 1981 *Robust statistics* (New York: Wiley)

Fox J 2002 *An R and S-PLUS Appendix Companion to Applied Regression*

## « Parabolic » smoothing

Table 1

Each pixel intensity is replaced by a weighted average over the neighbouring pixels

1/16	1/8	1/16
1/8	1/4	1/8
1/16	1/8	1/16

This modifies the uncertainty of pixel  $i$  which becomes:

$$\Delta I_i = \sqrt{\sum_j (w_j \cdot \Delta_j)^2}$$

*Bevington P.R., Data reduction and error analysis, McGraw-Hill, (1969)*

## Pseudo-calibration file

Assume that the detector cells efficiency is mostly due to the pre-amplifiers efficiency. For most gaz detector there is one preamplifier for each line and column. Thence the trick: Calculate 2 vectors as the average of each line  $\vec{A}_i$  and each column  $\vec{B}_j$

and build a new calibration file  $C^*$  as a normalised external product of these 2 vectors

$$[C^*] = \frac{1}{\hat{C}} \vec{A}_i^t \otimes \vec{B}_j$$

$\hat{C}$  is the average of the calibration file

The uncertainty is reduced by a factor equal to the number of cells in a row. This works very well for calibrators as vanadium or Plexiglas, not so well for H<sub>2</sub>O as it exhibits a « cuvette » effect at larger Q.

*Lindner P., Leclercq F., ILL*

# Simulated annealing

Fighting local minima:

Accept worse solutions to allow for a more extensive search for the optimal solution.

The name and inspiration come from [annealing in metallurgy](#), a technique involving heating and controlled cooling of a material to improve its properties.

Initialization of the method:

- determine a parameter **neighbourhood** where the **parameters will be picked randomly**
- chose a start « **temperature** » **T**
- the system **energy E** will be the function to minimize:  $\chi^2$  in our case
- define an **acceptance function P**
- if  $P < \text{random number } [0,1]$  go to the new parameter set

$$P = \exp\left(-\frac{\Delta E}{T}\right)$$

For a given T define a maximum number of trials, nTrials (it may be one)

- define how to decrease T and a maximum number of steps

**Problem: costly in computing time**

# Important

## During experiment:

- pay attention to **the statistics**, especially for the **calibration file** and the **sample holder (cuvette) file** .
- if this latter is very small versus the calibration forget it !

## During preliminary data treatment (corrections)

- if some pixels exhibit small counting rate perform a **smoothing of the data**, in order to avoid Poisson distribution, which may spoil the fit.
- if you feel the calibration file statistics are poor, try the **pseudo-calibration**.

## During the fit

- **if the test function is a  $\chi^2$  its final value must be close to 1.**  
**This is an excellent test of the quality of the model**  
and shows that a false minimum has been avoided,
- if it keeps far from 1, it means either
  - that the set of parameters is trapped in **a local minimum**
  - or that there is a **systematic error**.

Especially when statistics are poor a fit often goes amok if there are many parameters. In a first phase keep some parameters static. Run the fit. Finally free all parameters and run the fit again.

## Origin of systematic errors

- **bad centre definition.** When the scattering function changes very fast at small  $q$  it is very sensitive to the beam centre position (for instance power law). A 2D fit including the centre coordinates usually solves this problem.
- **bad model.** Gaussian and Lorentzian are very similar at small scattering vector  $Q$ , but much different at larger  $Q$ . Impurities or surface scattering may generate power law scattering, which must be added to the main model function.
- **detector electronics.** May happen while uncommon. Erroneous pixels are found mostly on the detector border; it is easy to remove them during the corrections stage.

## Advantage of 2D

- single  $I(0)$
- use of all pixels of non isotropic data
- higher reliability for parameter comparison in various directions
- centre fit

## Ethics

In your model use as little functions and parameters as possible.

It is always possible and meaningless to fit data with a lot of functions and parameters.

If you have 2 models compare them to the data. If both fit inside the data error bars, discard the most sophisticated.

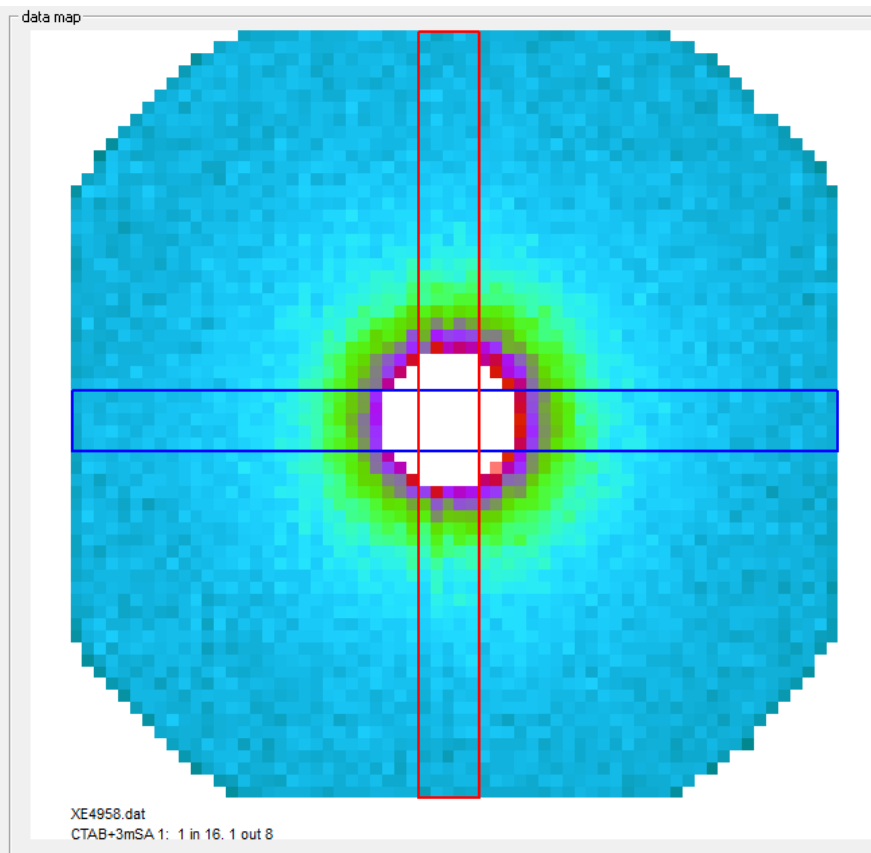
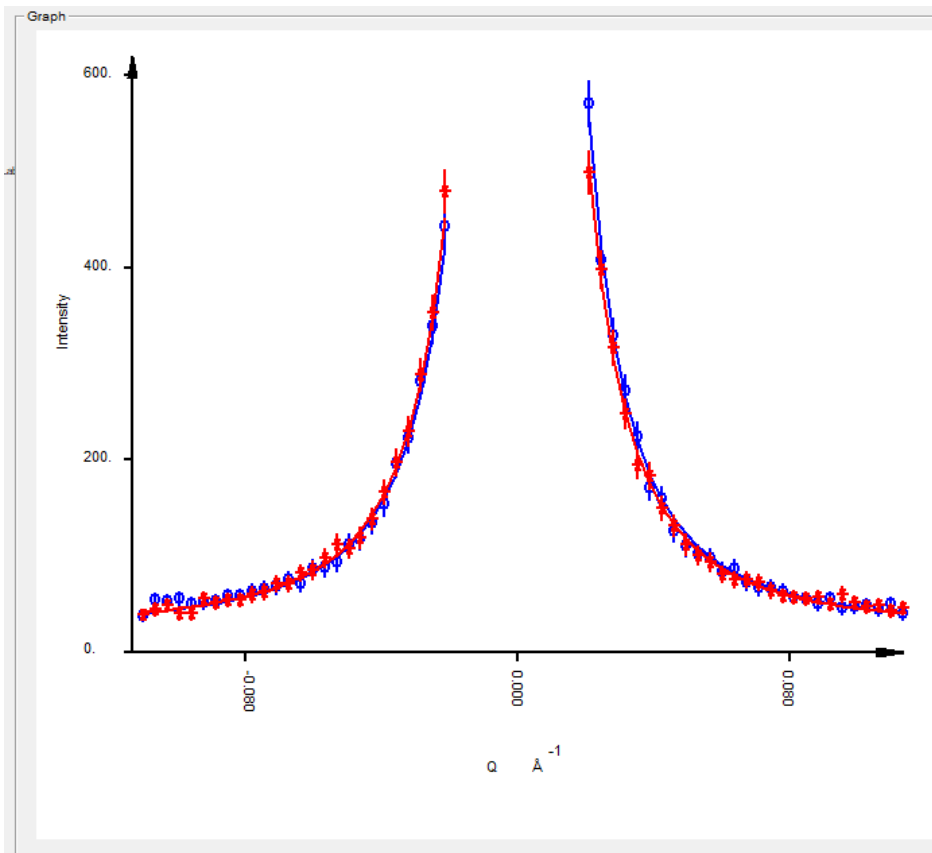
If you are not happy with that make again your experiment with better statistics.

# Examples

- a) Is there any anisotropy in my data?
- b) A problem of systematic error (Porod contamination) and statistics
- c) Again a systematic error (centre position). Why it is interesting to subtract the model to the data.
- d) The anisotropic scattering by a liquid crystal polymer chain is spoiled by a smectic Bragg peak
- e) 2 data files fitted with a single model
- f) Représentation and model function in polar coordinates
- g) « Embedded » data files, fitted together
- h) SAXS by perfect nanochannels (track etched polymer membranes)
- i) SANS by nanochannels (mica) , 2 data files together
- g) Is the main chain of polymer nanotubes anisotropic ?
- h) Again a systematic error (wrong model). Influence of the statistics of the calibration and sample holder file

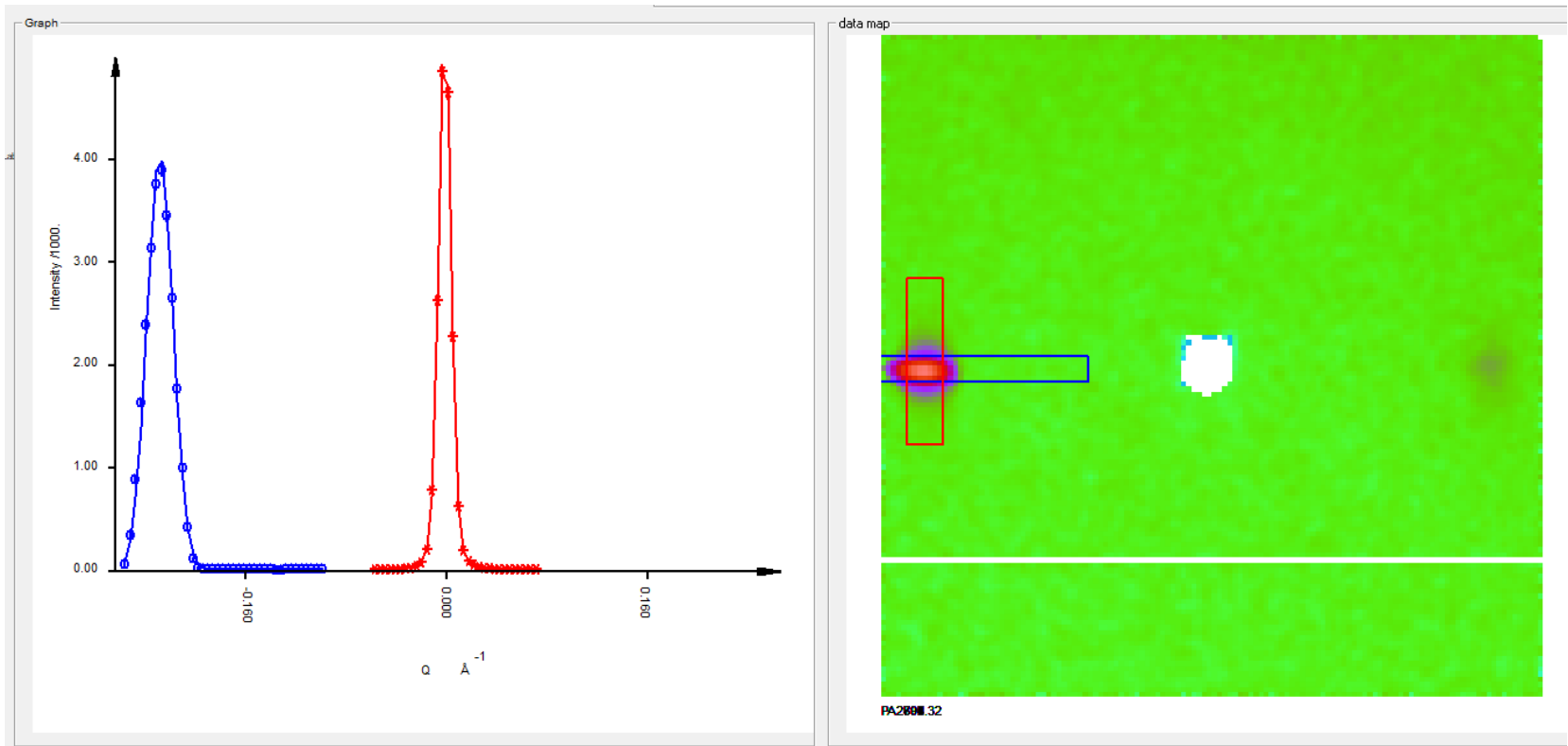


# Is there any anisotropy ?

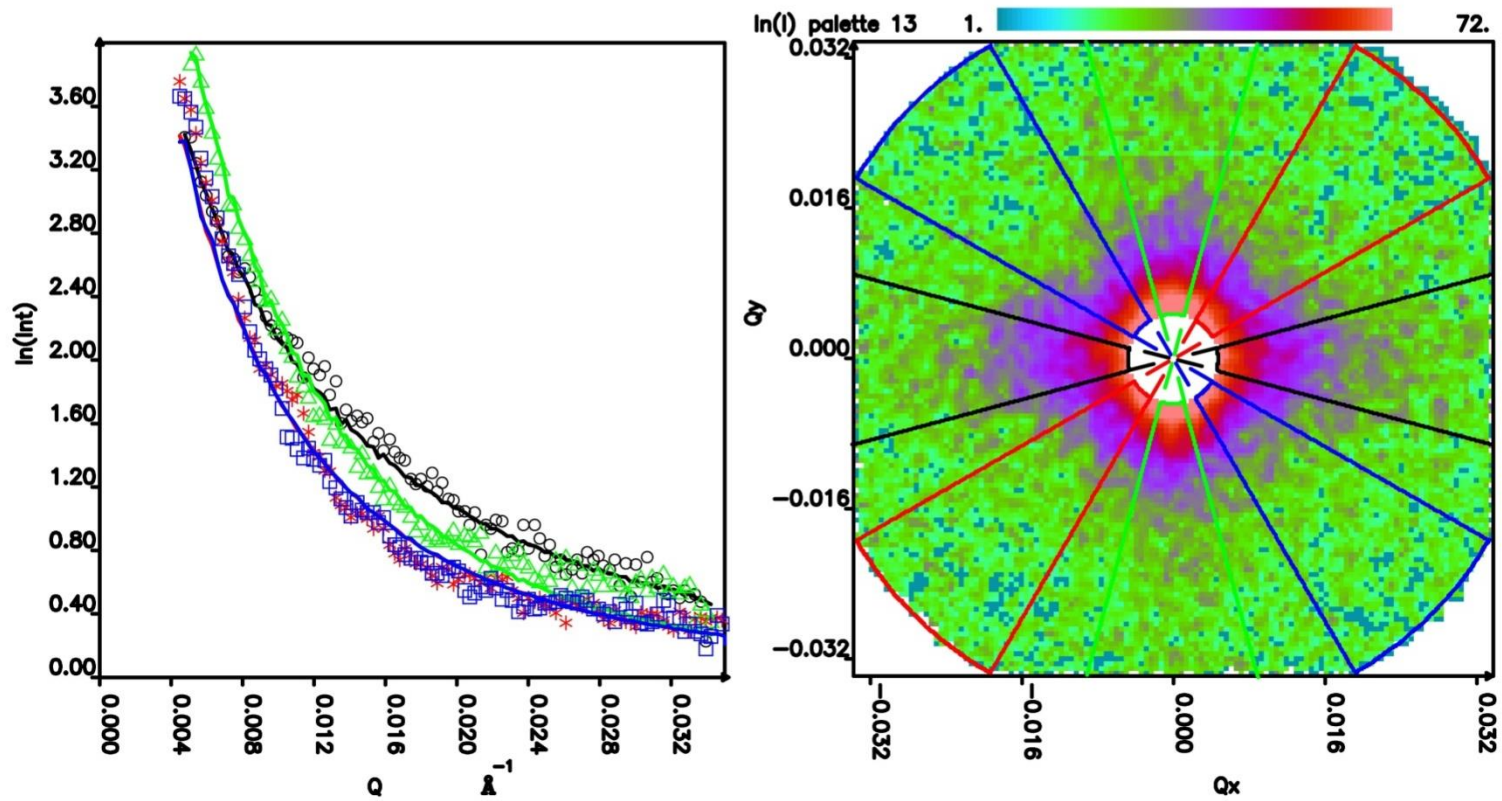


*Pépy G. BNC*

# Systematic error (wrong model). Influence of correction file statistics.

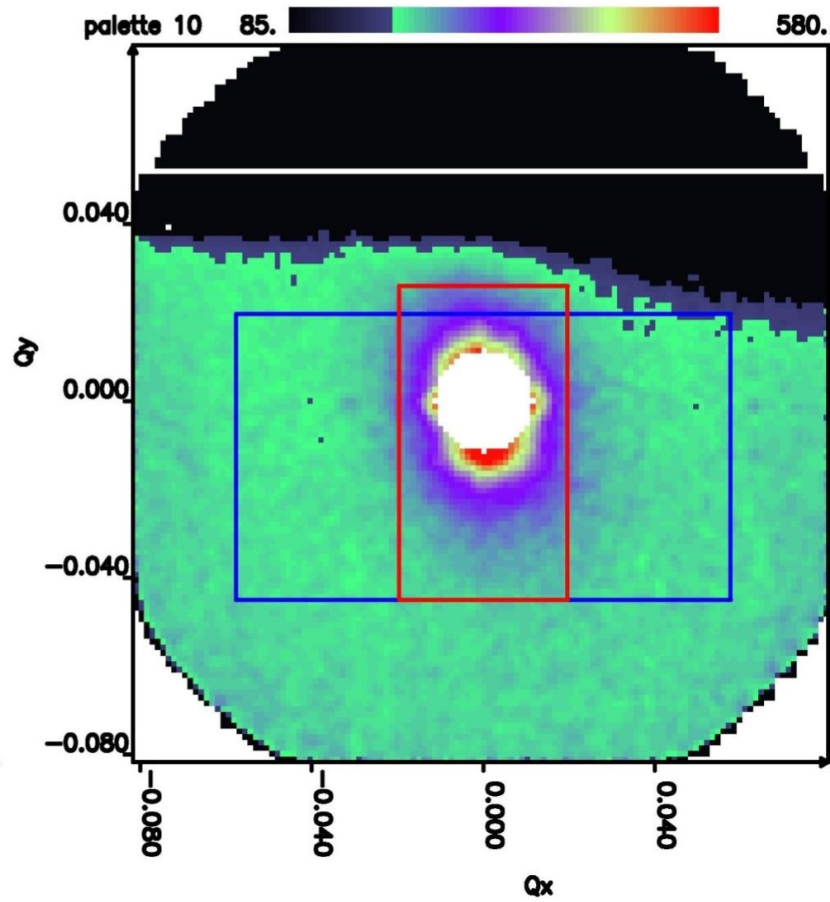
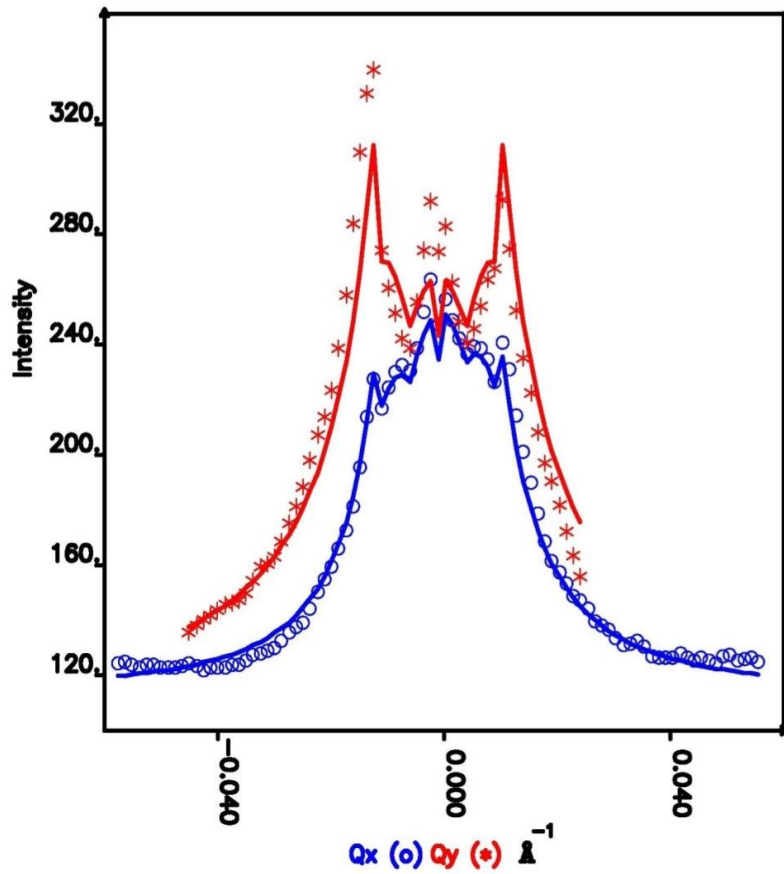


# Poor statistics, Porod contamination



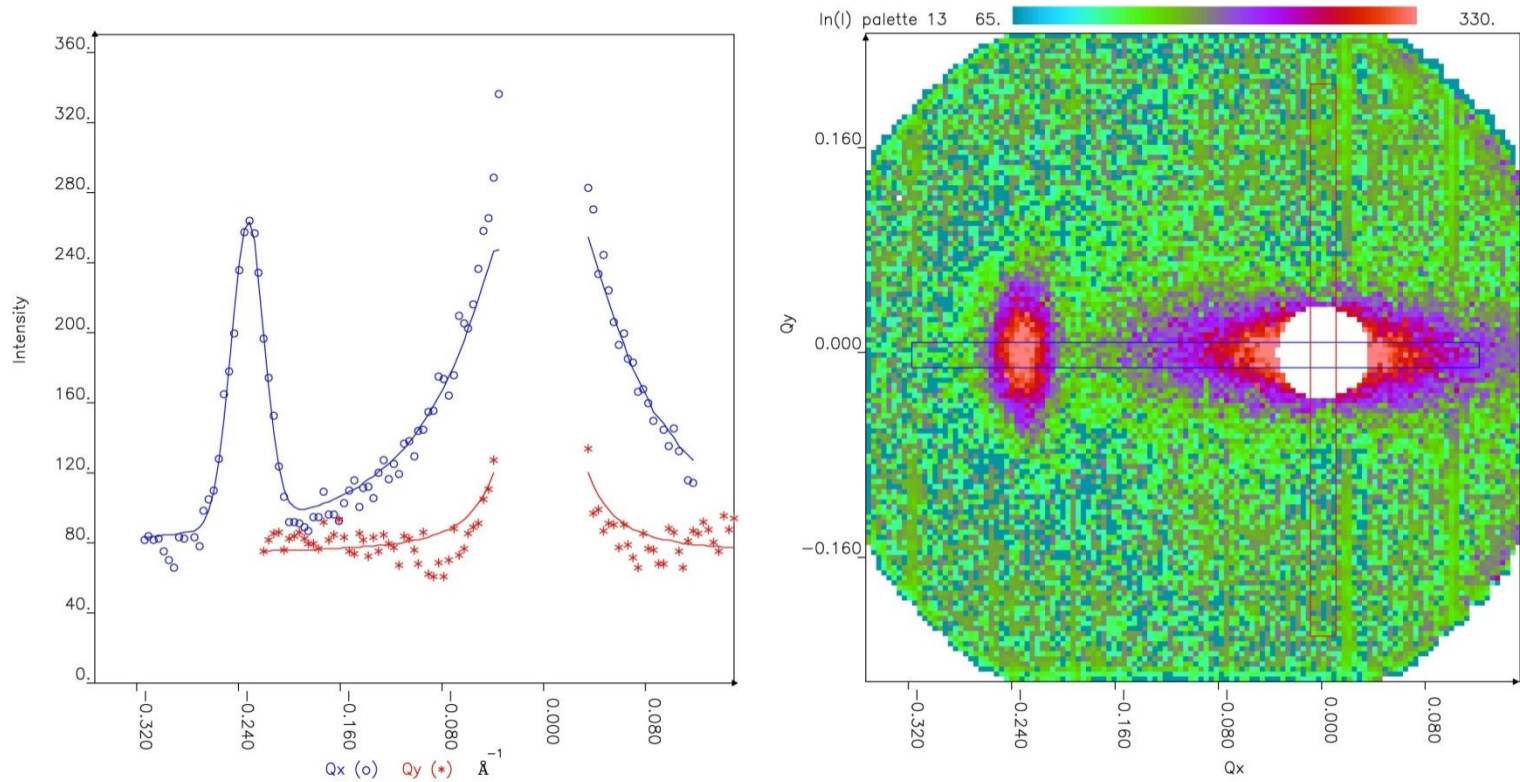
Mauzac M. CNRS

Find the origin of a systematic error...



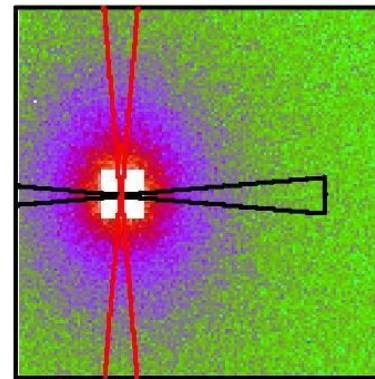
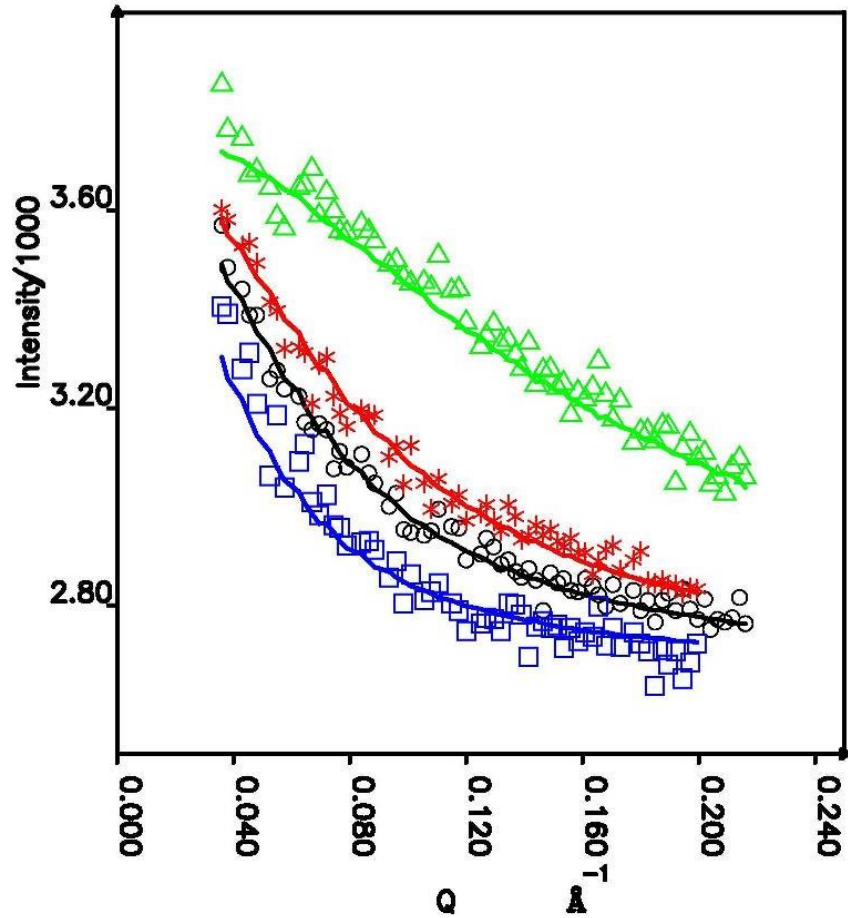
Noirez L. LLB

# Nice polymer chain central scattering, with a smectic Bragg peak near-by

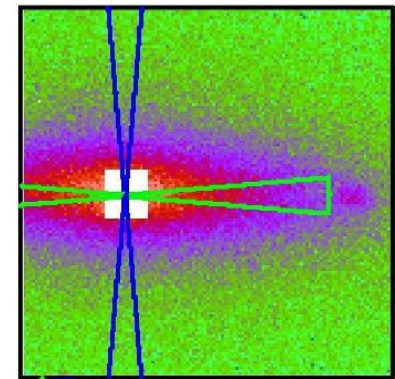


Cotton J.P. LLB

# How the shape of a liquid crystal polymer changes with temperature

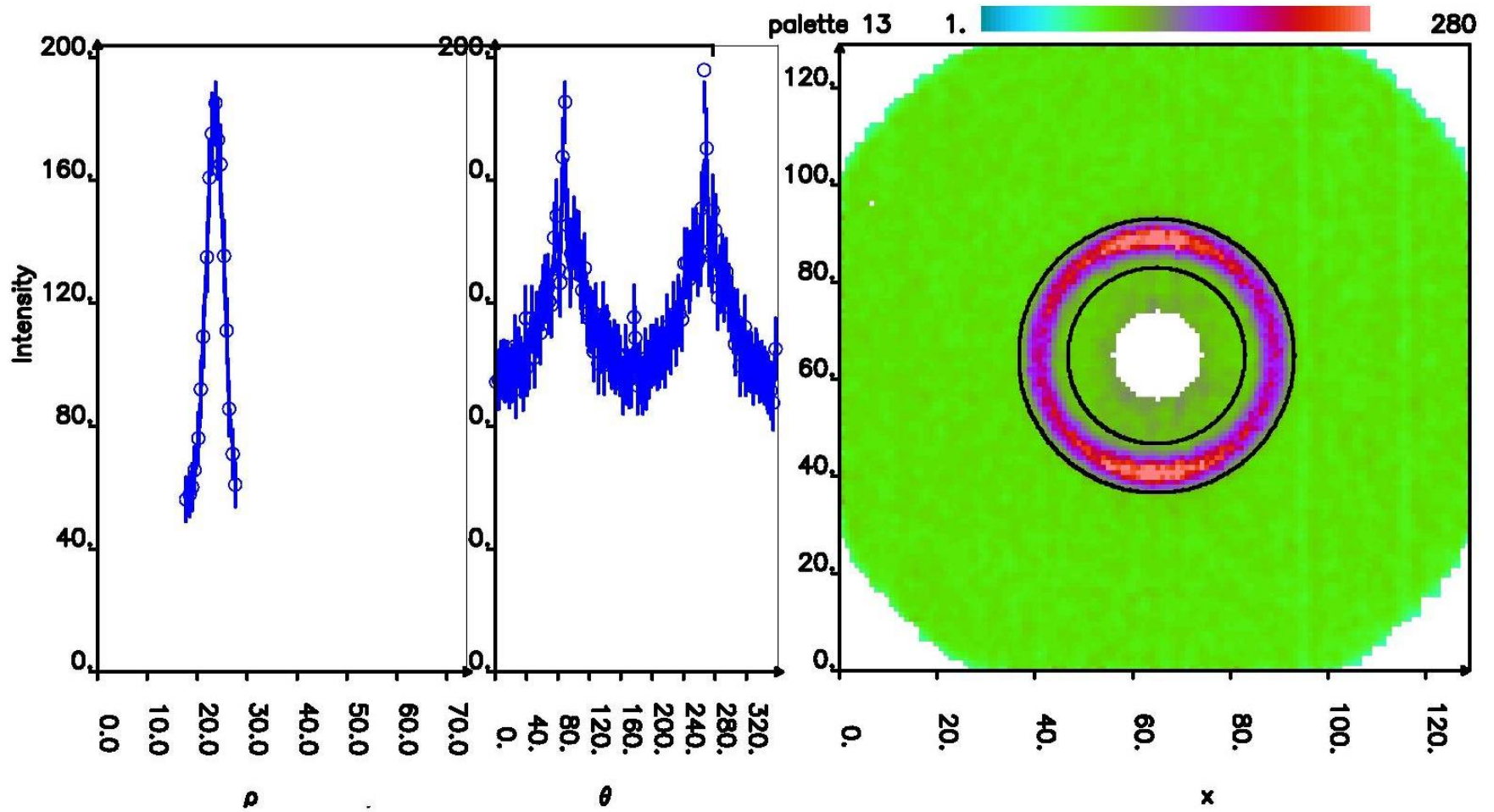


○\* 070908  
Crystals  $\Theta_{ALPA}(1)/PA(\quad 0.00^\circ \quad 0.00^\circ$



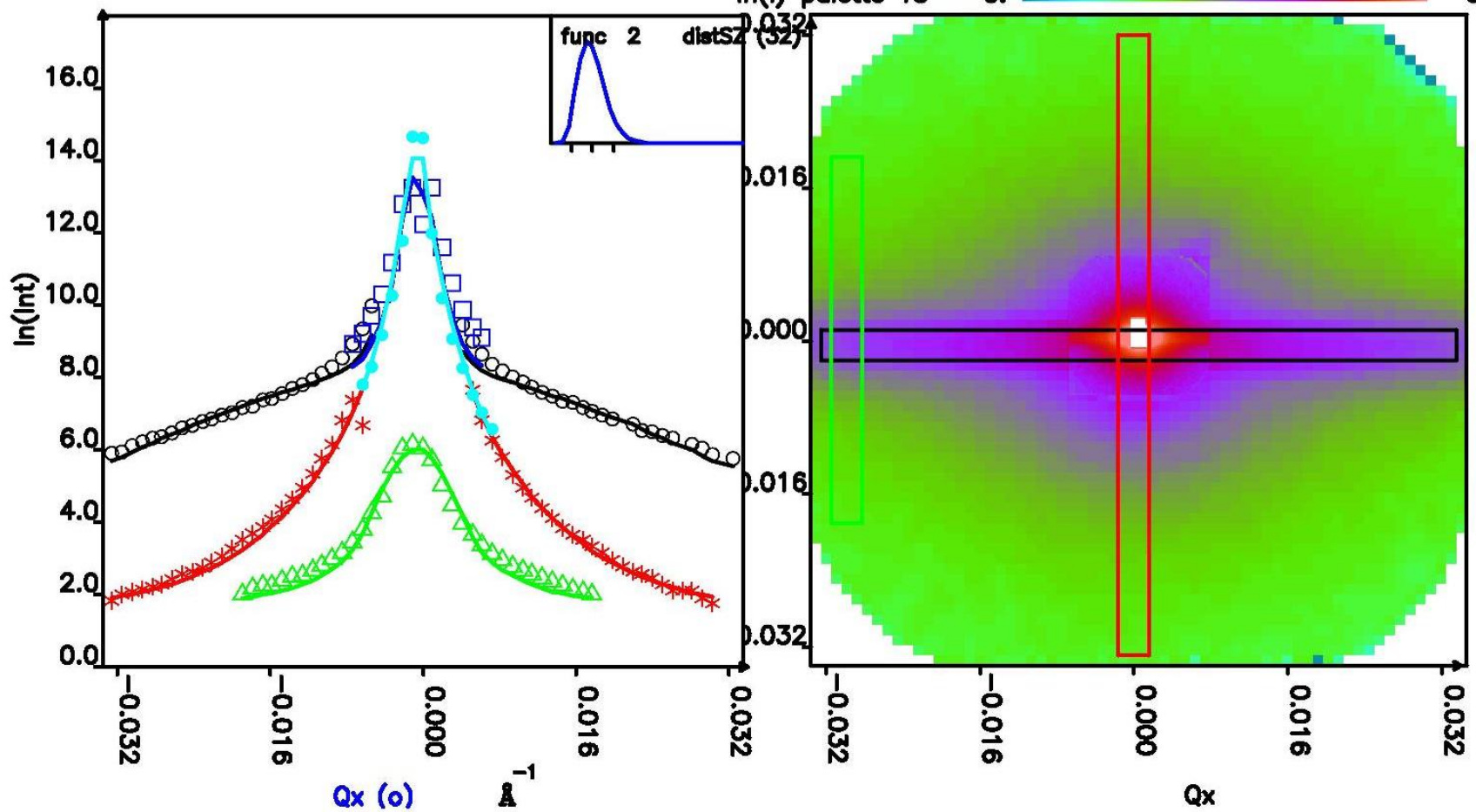
△□ 070906  
Crystals  $\Theta_{ALPA}(1)/PA(\quad 0.00^\circ \quad 0.00^\circ$

# Polar representation may be helpful



*Kiselev, JINR*

# Bubbles in W wires. Large Q scale.

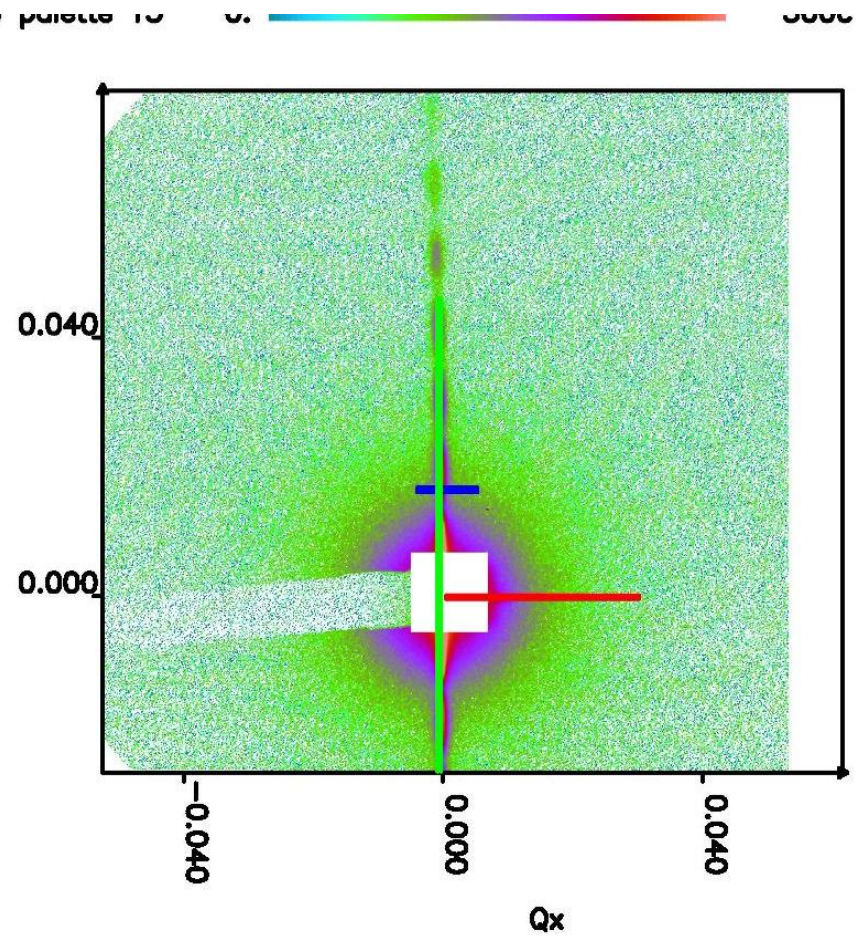
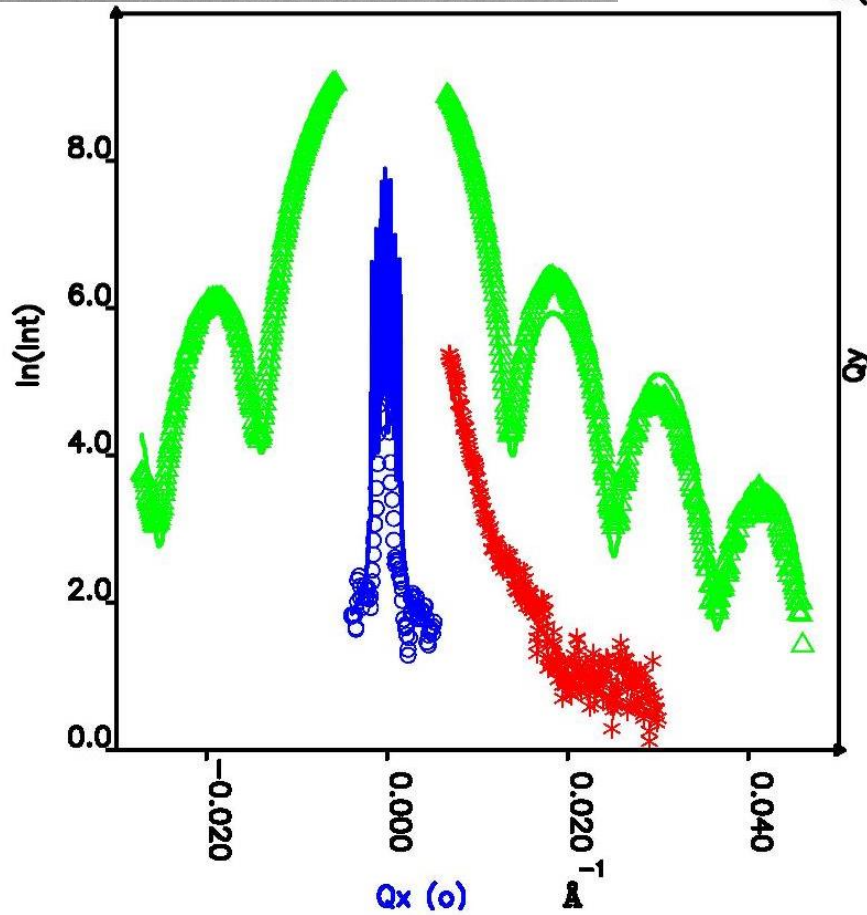
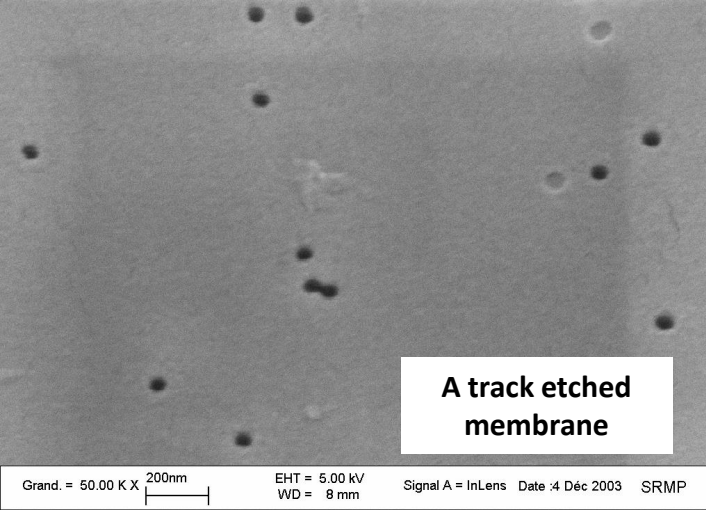


Len A. BNC

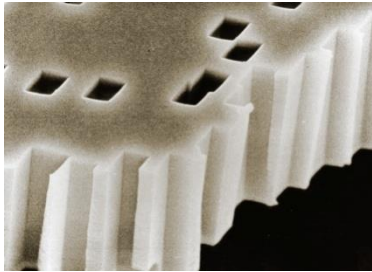


# SAXS by nanochannels

*Apel, Kuklin JINR*



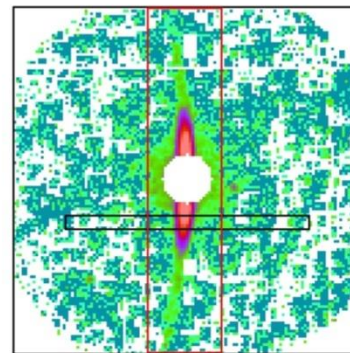
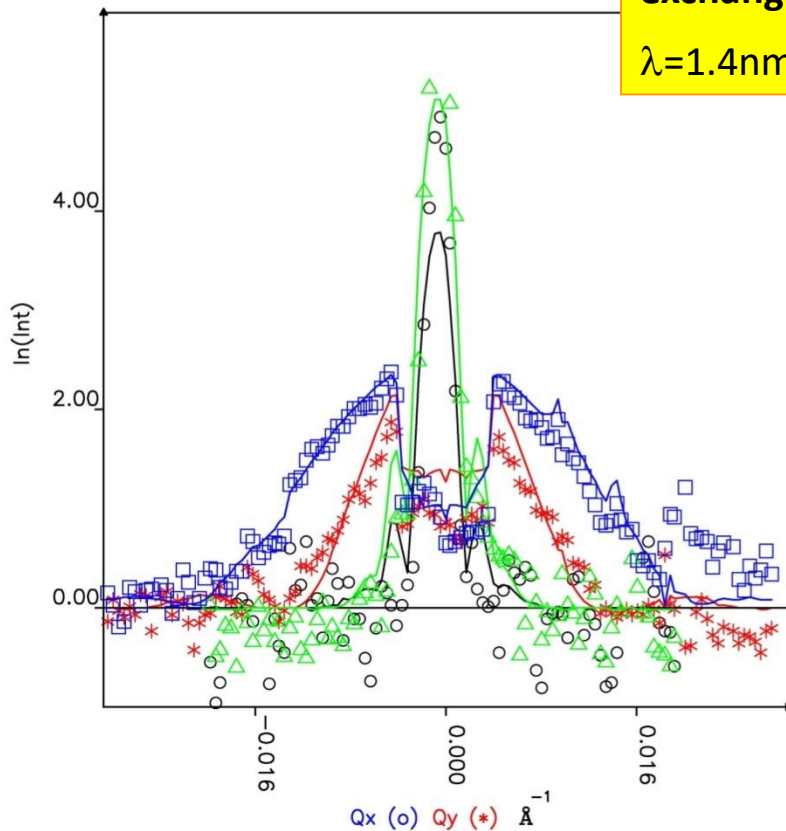
# SANS by rhombohedral nanochannels in mica



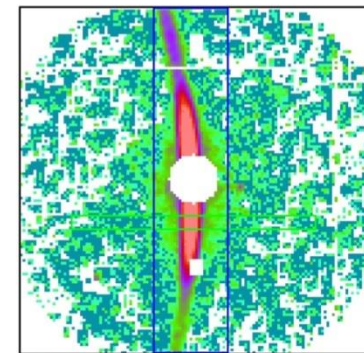
The data files were obtained at the LLB, Saclay, for two orientations of the channels at  $90^\circ$ .

**Both files were fitted together, with the same function, exchanging Ra, Rb**

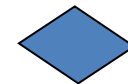
$\lambda=1.4\text{nm}$   $D=14\text{m}$   $R_a=45\text{nm}$   $R_b=25\text{nm}$



○ \* xy2547.32  
Nanoch mica 75 |

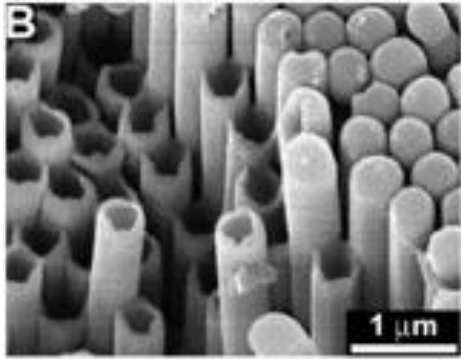


△ □ xy2548.32  
Nanoch mica 75 -



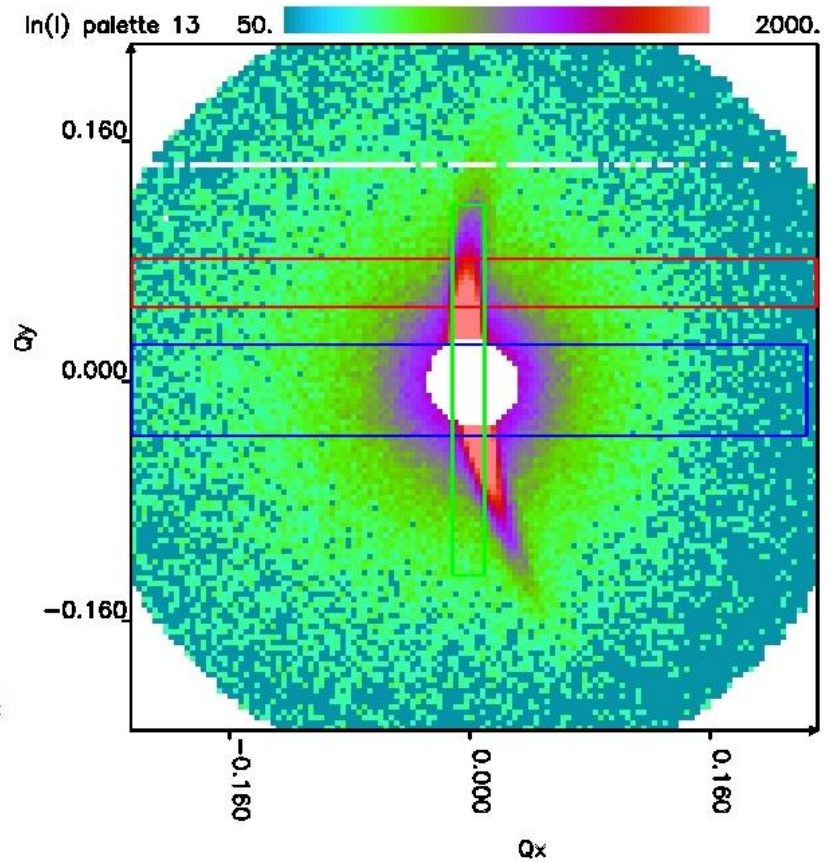
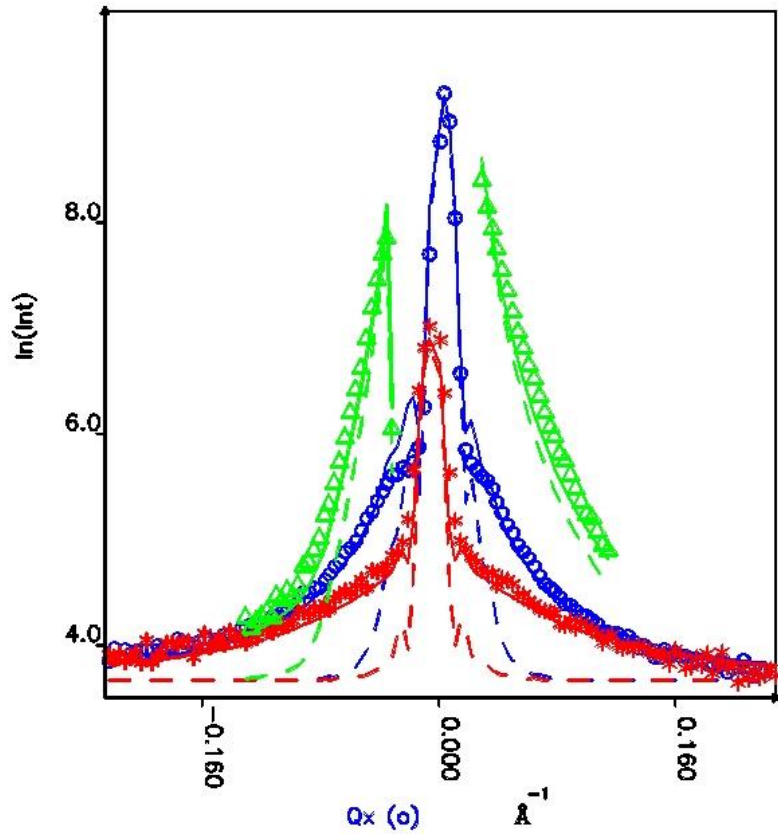
rhomboedric channel orientation

*C. Trautmann, GSI, Germany*



Is the main chain of polymer nanotubes anisotropic ?

*Stillings, Germany*



## Thanks to contributors

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Dear students, it would be nice to tell me wether

- this lecture **was interesting**
- this lecture **was not what you expected**
- what was **most** interesting
- what I may **remove**
  
- **improvements ?**

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*Thanks to the audience for the attention !*